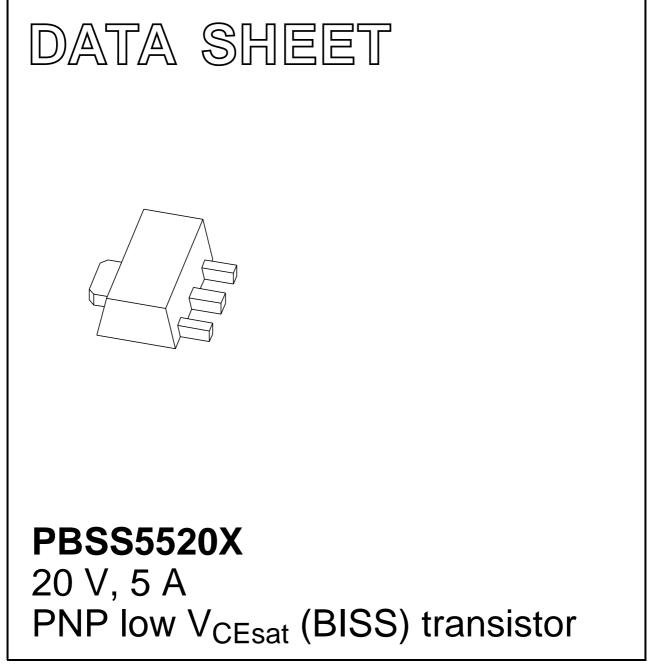
DISCRETE SEMICONDUCTORS



Product data sheet Supersedes data of 2004 Jun 23 2004 Nov 08



20 V, 5 A PNP low V_{CEsat} (BISS) transistor

FEATURES

- High h_{FE} and low V_{CEsat} at high current operation
- High collector current I_C: 5 A
- High efficiency leading to less heat generation.

APPLICATIONS

- Medium power peripheral drivers (e.g. fans and motors)
- Strobe flash units for digital still cameras and mobile phones
- Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- Battery chargers
- Supply line switching.

DESCRIPTION

PNP low V_{CEsat} (BISS) transistor in a SOT89 (SC-62) plastic package. NPN complement: PBSS4520X.

MARKING

TYPE NUMBER	MARKING CODE ⁽¹⁾
PBSS5520X	*1K

Note

- 1. * = p: made in Hong Kong.
 - * = t: made in Malaysia.
 - * = W: made in China.

ORDERING INFORMATION

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT	
V _{CEO}	collector-emitter voltage	-20	V	
I _C	collector current (DC)	-5	А	
I _{CM}	peak collector current	-10	А	
R _{CEsat}	equivalent on-resistance	54	mΩ	

PINNING

PIN	DESCRIPTION	
1	emitter	
2	collector	
3	base	

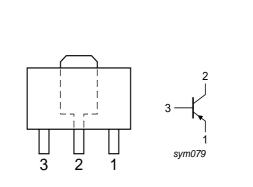


Fig.1 Simplified outline (SOT89) and symbol.

TYPE NUMBER		PACKAGE		
NAME		DESCRIPTION	VERSION	
PBSS5520X	SC-62	SC-62 plastic surface mounted package; collector pad for good heat transfer; 3 leads		

PBSS5520X

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	-20	V
V _{CEO}	collector-emitter voltage	open base	-	-20	V
V _{EBO}	emitter-base voltage	open collector	-	-5	V
I _C	collector current (DC)		-	-5	А
I _{CM}	peak collector current	t _p ≤ 1 ms	—	-10	A
I _{CRP}	repetitive peak collector current	notes 1 and 2	-	-6.5	А
I _B	base current (DC)		-	-1	А
I _{BM}	peak base current	t _p ≤ 1 ms	—	-2	A
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$			
		notes 1 and 2	—	2.5	W
		note 2	—	0.55	W
		note 3	_	1	W
		note 4	_	1.4	W
		note 5	_	1.6	W
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T _{amb}	ambient temperature		-65	+150	°C

Notes

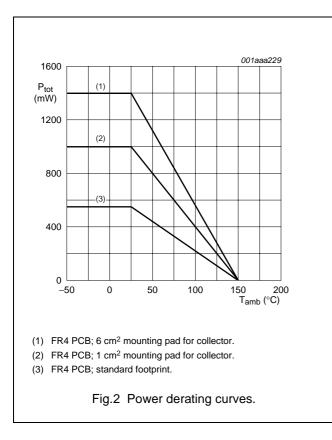
1. Operated under pulsed conditions; pulse width $t_p \leq$ 10 ms; duty cycle $\delta \leq$ 0.2.

2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.

3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm².

4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm².

5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper, tin-plated.



PBSS5520X

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction to ambient	in free air		
		notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R _{th(j-s)}	thermal resistance from junction to soldering point		16	K/W

Notes

- 1. Operated under pulsed conditions; pulse width $t_p \leq$ 10 ms; duty cycle $\delta \leq$ 0.2.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper, tin-plated.

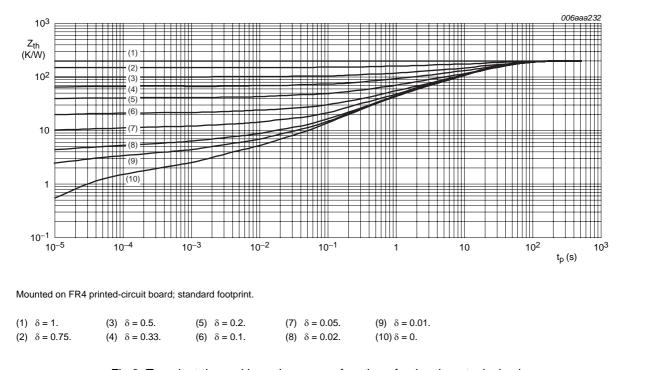
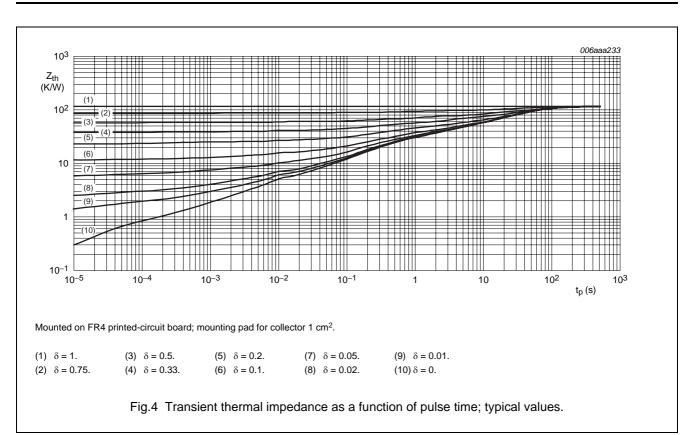
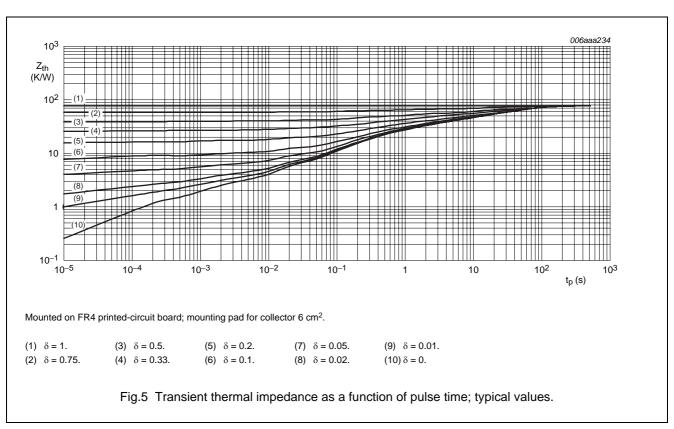


Fig.3 Transient thermal impedance as a function of pulse time; typical values.





20 V, 5 A PNP low V_{CEsat} (BISS) transistor

PBSS5520X

CHARACTERISTICS

 T_{amb} = 25 °C unless otherwise specified.

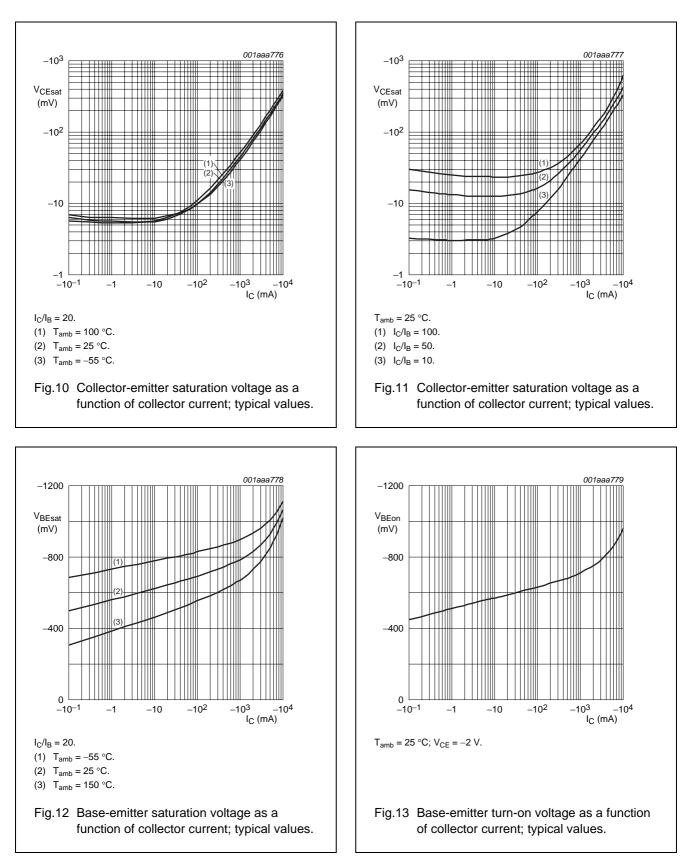
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A}$	_	_	-100	nA
		$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A}; T_j = 150 \text{ °C}$	-	-	-50	μA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; \text{ I}_{C} = 0 \text{ A}$	-	-	-100	nA
I _{CES}	collector-emitter cut-off current	$V_{CE} = -20 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -2 V$				
		I _C = -0.5 A; note 1	300	430	-	
		I _C = -1 A; note 1	275	400	-	
		I _C = -2 A; note 1	250	360	-	
		I _C = -5 A; note 1	150	260	-	
V _{CEsat}	collector-emitter saturation voltage	$I_{\rm C} = -0.5 \text{ A}; I_{\rm B} = -5 \text{ mA}$	_	-45	-70	mV
		$I_{\rm C} = -1$ A; $I_{\rm B} = -10$ mA	_	-70	-110	mV
		$I_{C} = -2.5 \text{ A}; I_{B} = -125 \text{ mA}; \text{ note } 1$	_	-100	-150	mV
		$I_{\rm C} = -4$ A; $I_{\rm B} = -200$ mA; note 1	_	-150	-230	mV
		$I_{C} = -5 \text{ A}; I_{B} = -500 \text{ mA}; \text{ note } 1$	_	-170	-270	mV
R _{CEsat}	equivalent on-resistance	$I_{C} = -5 \text{ A}; I_{B} = -500 \text{ mA}; \text{ note } 1$	-	34	54	mΩ
V _{BEsat}	base-emitter saturation voltage	$I_{C} = -4 \text{ A}; I_{B} = -200 \text{ mA}; \text{ note } 1$	_	-0.9	-1.05	V
		$I_{C} = -5 \text{ A}; I_{B} = -500 \text{ mA}; \text{ note } 1$	_	-0.96	-1.1	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 V; I_{C} = -2 A$	_	-0.74	-0.85	V
f _T	transition frequency	I _C = -100 mA; V _{CE} = -10 V; f = 100 MHz	80	100	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	_	130	150	pF

Note

1. Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

001aaa772 001a -0.25 -1200 I_{C} (A) V_{BE} (1) (2) (3) (4) (5) -0.20 (mV) -800 (1) -0.15 (6) (7) (8) -(9)--0.10 -400(10) -0.05 0 0 -1.6 -2.0 V_{CE} (V) -10-1 -102 0 -0.4 -0.8 -1.2 -10 -103 -104 -1 I_C (mA) (1) $I_B = -64 \text{ mA}.$ (5) I_B = -38.4 mA. (8) $I_B = -19.2 \text{ mA.}$ $V_{CE} = -2 V.$ (1) $T_{amb} = -55 \ ^{\circ}C.$ (2) $I_B = -57.6 \text{ mA}.$ (6) $I_B = -32 \text{ mA}.$ (9) $I_B = -12.8 \text{ mA}.$ (2) $T_{amb} = 25 \circ C$. (3) $I_B = -51.2 \text{ mA.}$ (7) $I_B = -25.6$ mA. (10) $I_B = -6.4$ mA. (4) $I_B = -44.8$ mA. (3) $T_{amb} = 100 \ ^{\circ}C.$ Fig.6 Collector current as a function of Fig.7 Base-emitter voltage as a function of collector-emitter voltage; typical values. collector current; typical values. 001aaa774 001aaa775 1000 10² h_{FE} R_{CEsat} (Ω) 800 10 11111(1) 600 1 TTI (| ||(2) 400 ТЦ 10⁻¹ (3) 200 10⁻² 0 -10³ -10-1 -102 -103 -10-1 -102 -1 -10 -104 -10 -104 -1 I_C (mA) I_C (mA) $I_{\rm C}/I_{\rm B} = 20.$ $V_{CE} = -2 V.$ (1) T_{amb} = 100 °C. (1) $T_{amb} = 100 \circ C$. (2) $T_{amb} = 25 \circ C$. (2) $T_{amb} = 25 \circ C$. (3) $T_{amb} = -55 \ ^{\circ}C.$ (3) $T_{amb} = -55 \ ^{\circ}C.$

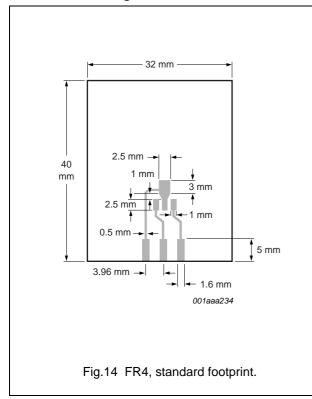
Fig.8 DC current gain as a function of collector current; typical values.

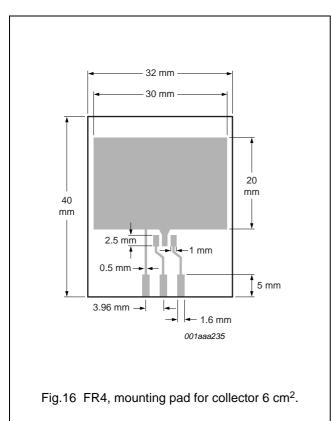


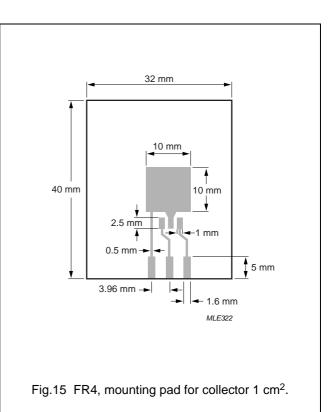
PBSS5520X

20 V, 5 A PNP low V_{CEsat} (BISS) transistor

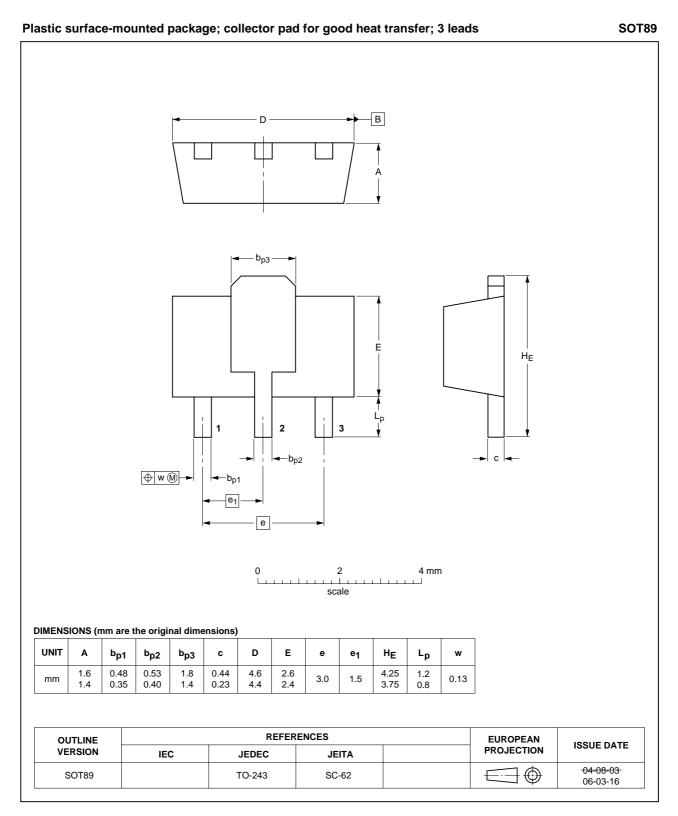
Reference mounting conditions







PACKAGE OUTLINE



PBSS5520X

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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